

XP152A12C0MR-G

TOREX

ETR1121_003

Power MOSFET

■ GENERAL DESCRIPTION

The XP152A12C0MR-G is a P-channel Power MOSFET with low on-state resistance and ultra high-speed switching characteristics.

Because high-speed switching is possible, the IC can be efficiently set thereby saving energy.

In order to counter static, a gate protect diode is built-in.

The small SOT-23 package makes high density mounting possible.

■ APPLICATIONS

- Notebook PCs
- Cellular and portable phones
- On-board power supplies
- Li-ion battery systems

■ FEATURES

Low On-State Resistance : $R_{ds(on)} = 0.3\Omega$ @ $V_{gs} = -4.5V$
: $R_{ds(on)} = 0.5\Omega$ @ $V_{gs} = -2.5V$

Ultra High-Speed Switching

Gate Protect Diode Built-in

Driving Voltage : -2.5V

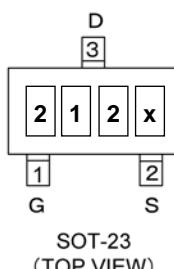
P-Channel Power MOSFET

DMOS Structure

Small Package : SOT-23

Environmentally Friendly : EU RoHS Compliant, Pb Free

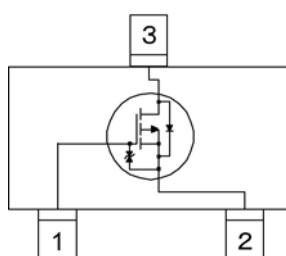
■ PIN CONFIGURATION/ MARKING



G : Gate
S : Source
D : Drain

* x represents production lot number.

■ EQUIVALENT CIRCUIT



P-channel MOSFET
(1 device built-in)

■ PIN ASSIGNMENT

PRODUCTS	PACKAGE	ORDER UNIT
XP152A12C0MR	SOT-23	3,000/Reel
XP152A12C0MR-G ^(*)	SOT-23	3,000/Reel

^(*) The "-G" suffix denotes Halogen and Antimony free as well as being fully RoHS compliant.

■ ABSOLUTE MAXIMUM RATINGS

T_a = 25°C

PARAMETER	SYMBOL	RATINGS	UNITS
Drain - Source Voltage	V _{dss}	-20	V
Gate - Source Voltage	V _{gss}	±12	V
Drain Current (DC)	I _d	-0.7	A
Drain Current (Pulse)	I _{dp}	-2.8	A
Reverse Drain Current	I _{dr}	-0.7	A
Channel Power Dissipation *	P _d	0.5	W
Channel Temperature	T _{ch}	150	°C
Storage Temperature	T _{stg}	-55~150	°C

* When implemented on a ceramic PCB

■ ELECTRICAL CHARACTERISTICS

DC Characteristics

T_a = 25°C

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Drain Cut-Off Current	Idss	V _{ds} = -20V, V _{gs} = 0V	-	-	-10	μA
Gate-Source Leak Current	I _{gss}	V _{gs} = ±12V, V _{ds} = 0V	-	-	±10	μA
Gate-Source Cut-Off Voltage	V _{gs(off)}	I _d = -1mA, V _{ds} = -10V	-0.5	-	-1.2	V
Drain-Source On-State Resistance *1	R _{ds(on)}	I _d = -0.4A, V _{gs} = -4.5V	-	0.23	0.30	Ω
		I _d = -0.4A, V _{gs} = -2.5V	-	0.37	0.50	Ω
Forward Transfer Admittance *1	Y _{fs}	I _d = -0.4A, V _{ds} = -10V	-	1.5	-	S
Body Drain Diode Forward Voltage	V _f	I _f = -0.7A, V _{gs} = 0V	-	-0.8	-1.1	V

*1 Effective during pulse test.

Dynamic Characteristics

T_a = 25°C

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Input Capacitance	C _{iss}	V _{ds} = -10V, V _{gs} = 0V f= 1MHz	-	180	-	pF
Output Capacitance	C _{oss}		-	120	-	pF
Feedback Capacitance	C _{rss}		-	60	-	pF

Switching Characteristics

T_a = 25°C

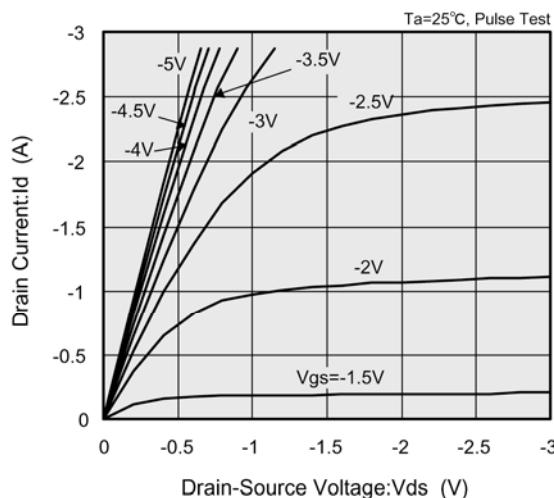
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Turn-On Delay Time	t _d (on)	V _{gs} = -5V, I _d = -0.4A V _{dd} = -10V	-	5	-	ns
Rise Time	t _r		-	20	-	ns
Turn-Off Delay Time	t _d (off)		-	55	-	ns
Fall Time	t _f		-	70	-	ns

Thermal Characteristics

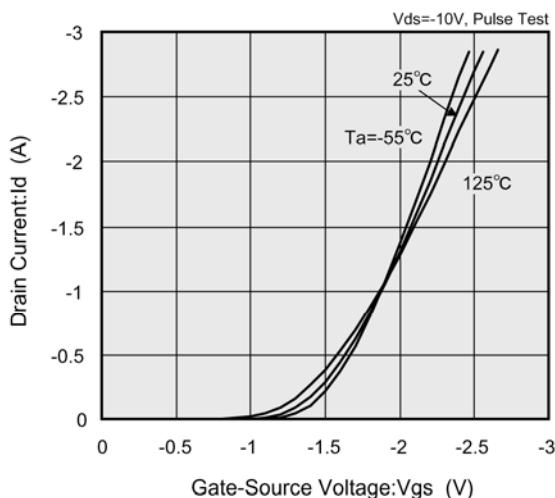
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Thermal Resistance (Channel-Ambience)	R _{th} (ch-a)	Implement on a ceramic PCB	-	250	-	°C/W

■ TYPICAL PERFORMANCE CHARACTERISTICS

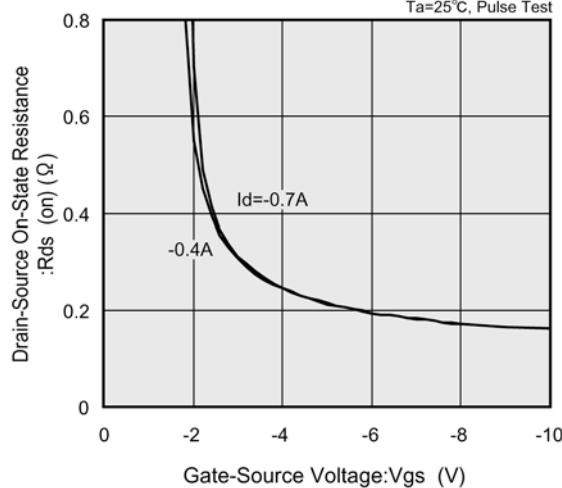
(1) Drain Current vs. Drain-Source Voltage



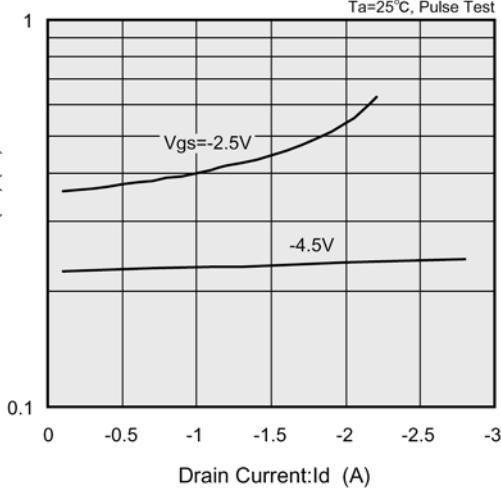
(2) Drain Current vs. Gate-Source Voltage



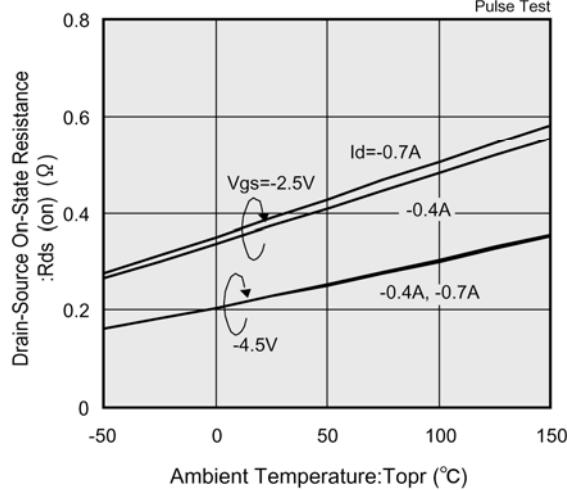
(3) Drain-Source On-State Resistance vs. Gate-Source Voltage



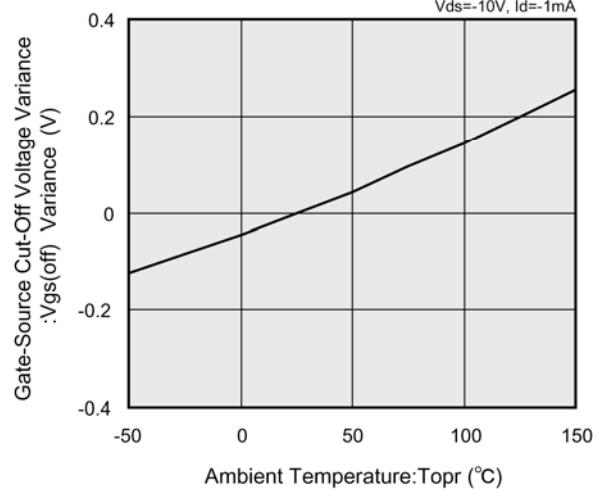
(4) Drain-Source On-State Resistance vs. Drain Current



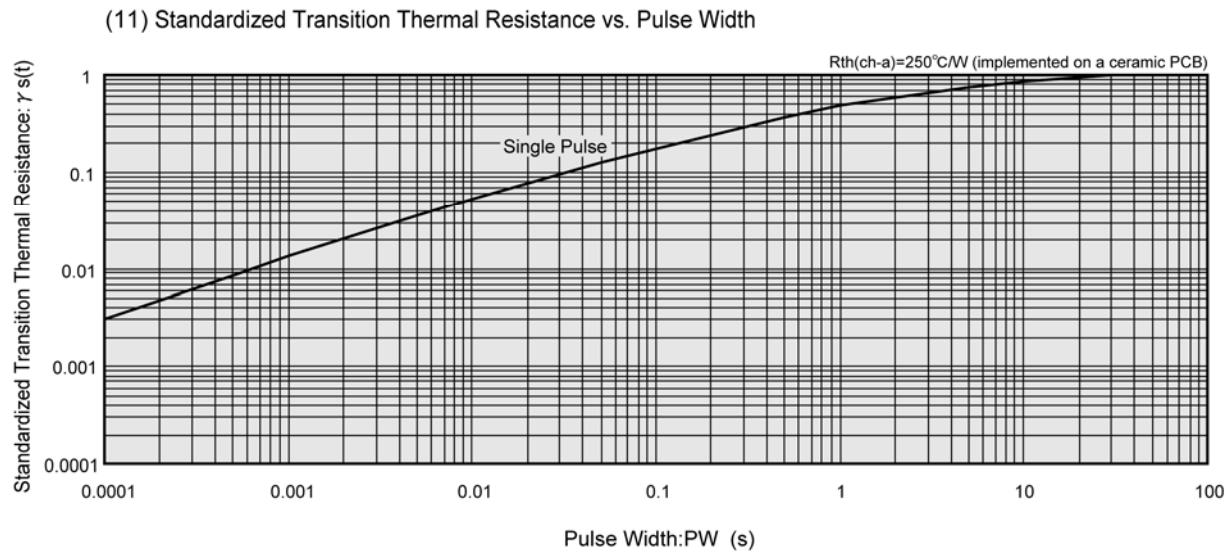
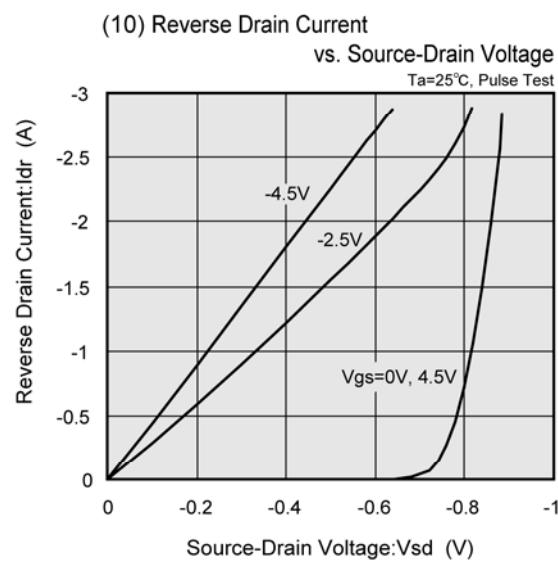
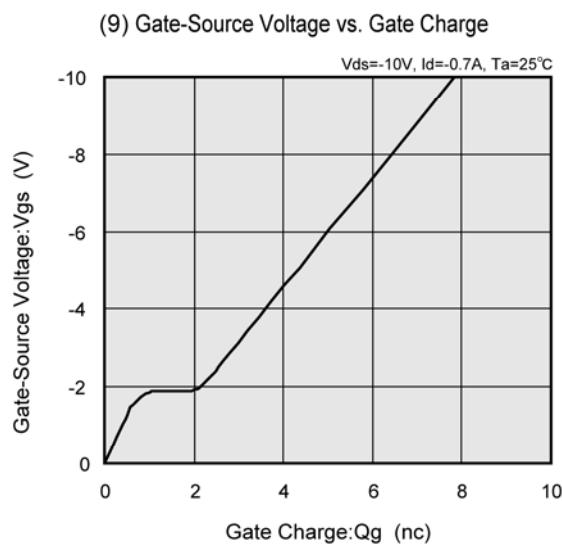
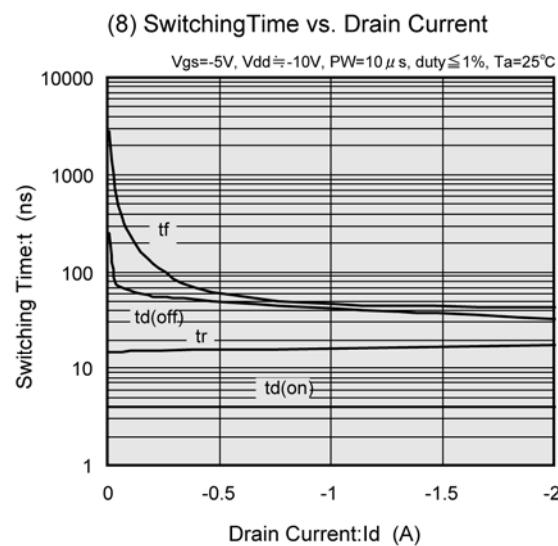
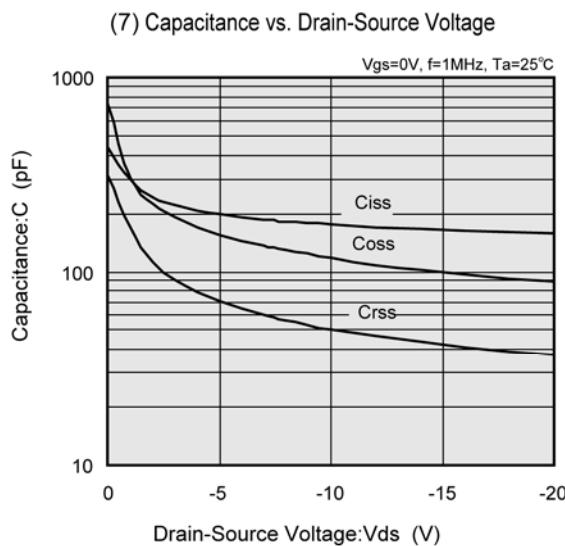
(5) Drain-Source On-State Resistance vs. Ambient Temperature



(6) Gate Source Cut-Off Voltage Variance vs. Ambient Temperature



■ TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



1. The products and product specifications contained herein are subject to change without notice to improve performance characteristics. Consult us, or our representatives before use, to confirm that the information in this datasheet is up to date.
2. We assume no responsibility for any infringement of patents, patent rights, or other rights arising from the use of any information and circuitry in this datasheet.
3. Please ensure suitable shipping controls (including fail-safe designs and aging protection) are in force for equipment employing products listed in this datasheet.
4. The products in this datasheet are not developed, designed, or approved for use with such equipment whose failure of malfunction can be reasonably expected to directly endanger the life of, or cause significant injury to, the user.
(e.g. Atomic energy; aerospace; transport; combustion and associated safety equipment thereof.)
5. Please use the products listed in this datasheet within the specified ranges. Should you wish to use the products under conditions exceeding the specifications, please consult us or our representatives.
6. We assume no responsibility for damage or loss due to abnormal use.
7. All rights reserved. No part of this datasheet may be copied or reproduced without the prior permission of TOREX SEMICONDUCTOR LTD.

TOREX SEMICONDUCTOR LTD.